



SPW35N60CFD

CoolMOS™ Power Transistor

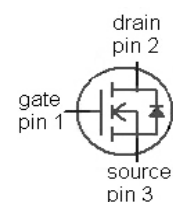
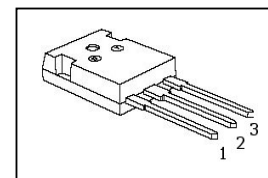
Features

- New revolutionary high voltage technology
- Intrinsic fast-recovery body diode
- Extremely low reverse recovery charge
- Ultra low gate charge
- Extreme dv/dt rated
- High peak current capability
- Periodic avalanche rated
- Qualified according to JEDEC¹⁾ for target applications
- Pb-free lead plating; RoHS compliant

Product Summary

V_{DS}	600	V
$R_{DS(on),max}$	0.118	Ω
I_D	34	A

PG-T0247



Type	Package	Ordering Code	Marking
SPW35N60CFD	PG-T0247	Q67045A5053	35N60CFD

Maximum ratings, at $T_j=25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_C=25\text{ °C}$	34.1	A
		$T_C=100\text{ °C}$	21.6	
Pulsed drain current ²⁾	$I_{D,pulse}$	$T_C=25\text{ °C}$	85	
Avalanche energy, single pulse	E_{AS}	$I_D=10\text{ A}$, $V_{DD}=50\text{ V}$	1300	mJ
Avalanche energy, repetitive $t_{AR}^{2),3)}$	E_{AR}	$I_D=20\text{ A}$, $V_{DD}=50\text{ V}$	1	
Avalanche current, repetitive $t_{AR}^{2),3)}$	I_{AR}		20	A
Drain source voltage slope	dv/dt	$I_D=34.1\text{ A}$, $V_{DS}=480\text{ V}$, $T_j=125\text{ °C}$	80	V/ns
Reverse diode dv/dt	dv/dt	$I_S=34.1\text{ A}$, $V_{DS}=480\text{ V}$, $T_j=125\text{ °C}$	40	V/ns
Maximum diode commutation speed	di/dt		600	A/ μ s
Gate source voltage	V_{GS}	static	± 20	V
		AC ($f>1\text{ Hz}$)	± 30	
Power dissipation	P_{tot}	$T_C=25\text{ °C}$	313	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150	°C



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Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}		-	-	0.4	K/W
Thermal resistance, junction - ambient	R_{thJA}	leaded	-	-	62	
Soldering temperature, wave soldering	T_{sold}	1.6 mm (0.063 in.) from case for 10 s	-	-	260	°C

Electrical characteristics, at $T_j=25\text{ °C}$, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}$, $I_D=250\text{ }\mu\text{A}$	600	-	-	V
Avalanche breakdown voltage	$V_{(BR)DS}$	$V_{GS}=0\text{ V}$, $I_D=34.1\text{ A}$	-	700	-	
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=1.9\text{ mA}$	3	4	5	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=600\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ °C}$	-	4	-	μA
		$V_{DS}=600\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=150\text{ °C}$	-	3300	-	
Gate-source leakage current	I_{GSS}	$V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{ V}$, $I_D=21.6\text{ A}$, $T_j=25\text{ °C}$	-	0.10	0.118	Ω
		$V_{GS}=10\text{ V}$, $I_D=21.6\text{ A}$, $T_j=150\text{ °C}$	-	0.23	-	
Gate resistance	R_G	$f=1\text{ MHz}$, open drain	-	0.6	-	
Transconductance	g_{fs}	$ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=21.6\text{ A}$	-	21	-	S



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Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}, V_{DS}=25\text{ V},$ $f=1\text{ MHz}$	-	5060	-	pF
Output capacitance	C_{oss}		-	1400	-	
Reverse transfer capacitance	C_{rss}		-	52	-	
Effective output capacitance, energy related ⁴⁾	$C_{o(er)}$	$V_{GS}=0\text{ V}, V_{DS}=0\text{ V}$ to 480 V	-	162	-	
Effective output capacitance, time related ⁵⁾	$C_{o(tr)}$		-	299	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=400\text{ V},$ $V_{GS}=10\text{ V}, I_D=34.1\text{ A},$ $R_G=3.3\ \Omega$	-	20	-	ns
Rise time	t_r		-	25	-	
Turn-off delay time	$t_{d(off)}$		-	65	-	
Fall time	t_f		-	12	-	

Gate Charge Characteristics

Gate to source charge	Q_{gs}	$V_{DD}=480\text{ V},$ $I_D=34.1\text{ A},$ $V_{GS}=0\text{ to }10\text{ V}$	-	36	-	nC
Gate to drain charge	Q_{gd}		-	87	-	
Gate charge total	Q_g		-	163	212	
Gate plateau voltage	$V_{plateau}$		-	7.2	-	V

¹⁾ J-STD20 and JESD22

²⁾ Pulse width t_p limited by $T_{j,max}$

³⁾ Repetitive avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR} \cdot f$.

⁴⁾ $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

⁵⁾ $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .



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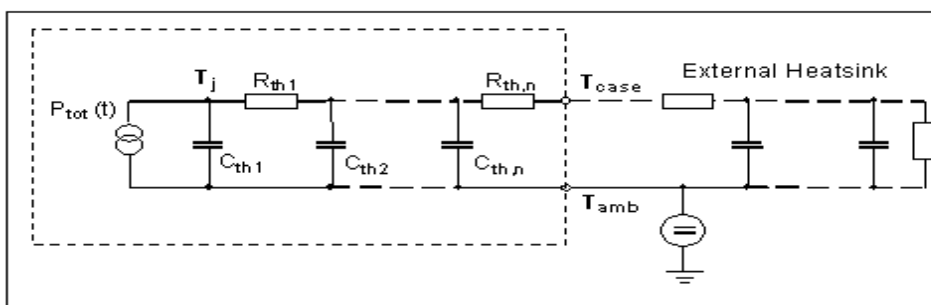
Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Reverse Diode

Diode continuous forward current	I_S	$T_C=25\text{ }^{\circ}\text{C}$	-	-	34.1	A
Diode pulse current	$I_{S,pulse}$		-	-	85	
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}, I_F=34.1\text{ A}, T_j=25\text{ }^{\circ}\text{C}$	-	1.0	1.2	V
Reverse recovery time	t_{rr}	$V_R=480\text{ V}, I_F=I_S, di_F/dt=100\text{ A}/\mu\text{s}$	-	180	-	ns
Reverse recovery charge	Q_{rr}		-	1.5	-	μC
Peak reverse recovery current	I_{rrm}		-	16	-	A

Typical Transient Thermal Characteristics

Symbol	Value	Unit	Symbol	Value	Unit
	typ.			typ.	
R_{th1}	0.00441	K/W	C_{th1}	0.00037	Ws/K
R_{th2}	0.00608		C_{th2}	0.00223	
R_{th3}	0.0341		C_{th3}	0.00315	
R_{th4}	0.0602		C_{th4}	0.0179	
R_{th5}	0.0884		C_{th5}	0.098	
			C_{th6}	4.4 ⁵⁾	



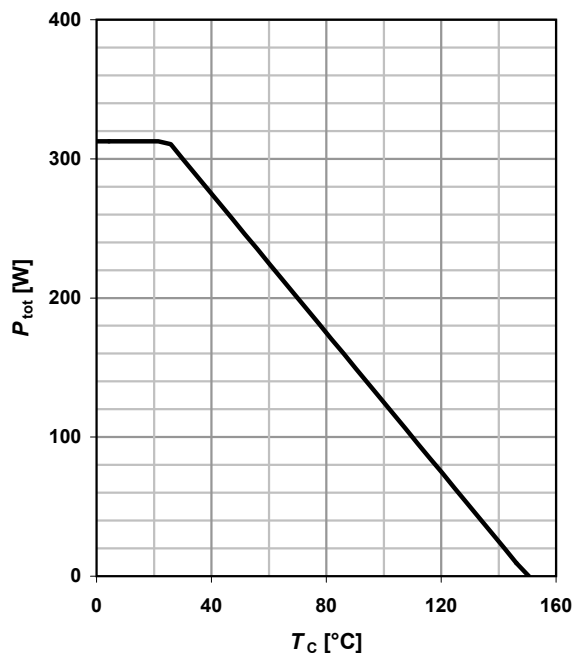
⁵⁾ C_{th6} models the additional heat capacitance of the package in case of non-ideal cooling. It is not needed if $R_{thCA}=0\text{ K/W}$.



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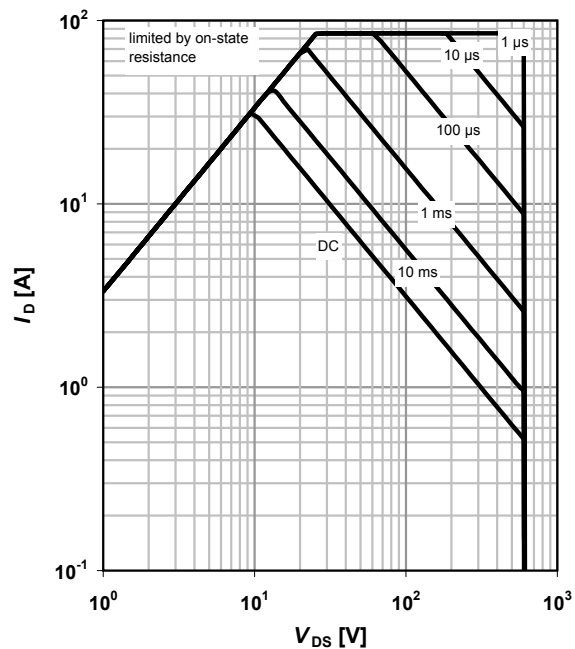
1 Power dissipation

$$P_{\text{tot}} = f(T_C)$$



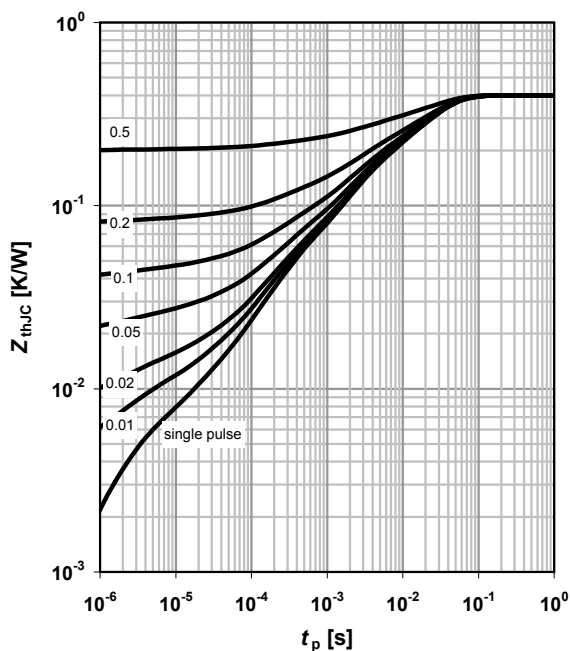
2 Safe operating area

$$I_D = f(V_{DS}); T_C = 25\text{ °C}; D = 0$$

parameter: t_p 

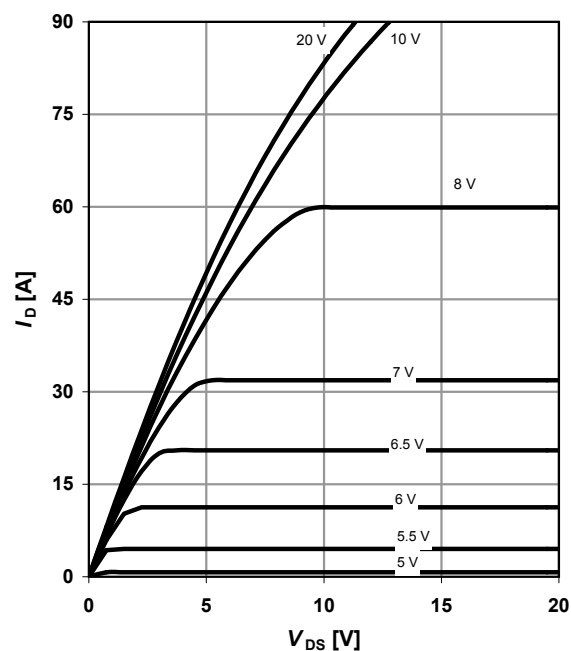
3 Max. transient thermal impedance

$$I_D = f(V_{DS}); T_J = 25\text{ °C}$$

parameter: $D = t_p/T$ 

4 Typ. output characteristics

$$I_D = f(V_{DS}); T_J = 25\text{ °C}$$

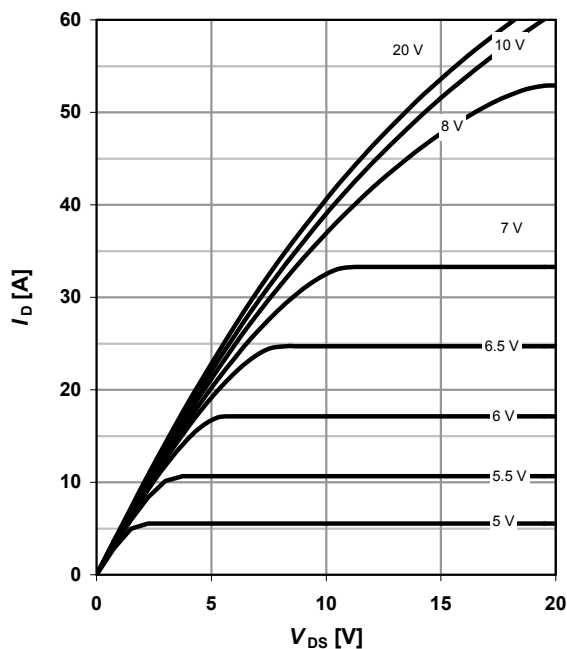
parameter: V_{GS} 



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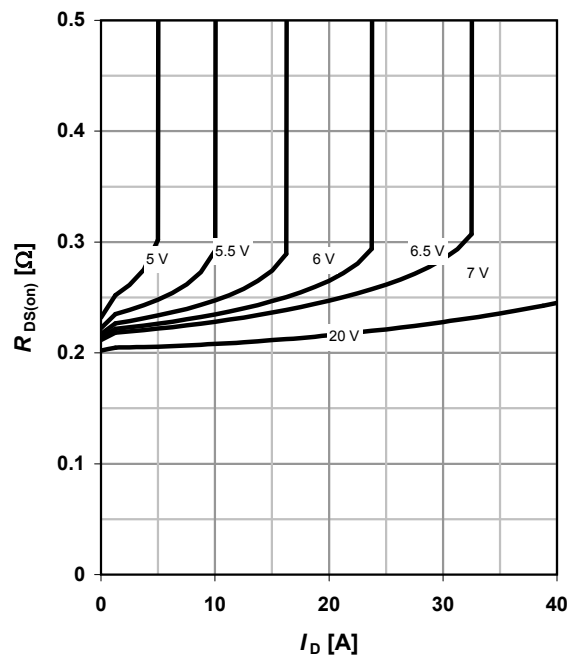
5 Typ. output characteristics

$$I_D = f(V_{DS}); T_J = 150^\circ\text{C}$$

parameter: V_{GS} 

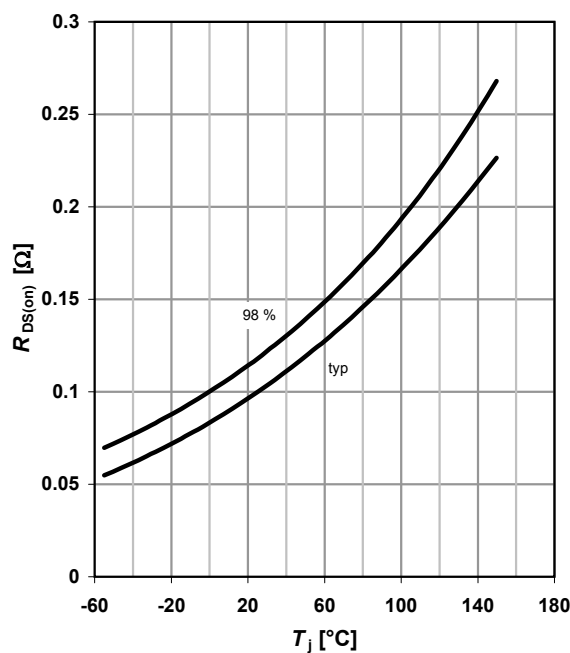
6 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(I_D); T_J = 150^\circ\text{C}$$

parameter: V_{GS} 

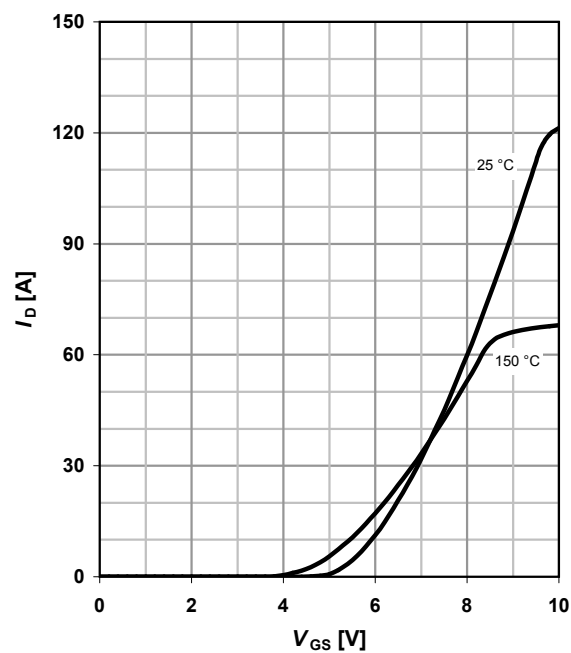
7 Drain-source on-state resistance

$$R_{DS(on)} = f(T_J); I_D = 21.9\text{ A}; V_{GS} = 10\text{ V}$$



8 Typ. transfer characteristics

$$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)\text{max}}$$

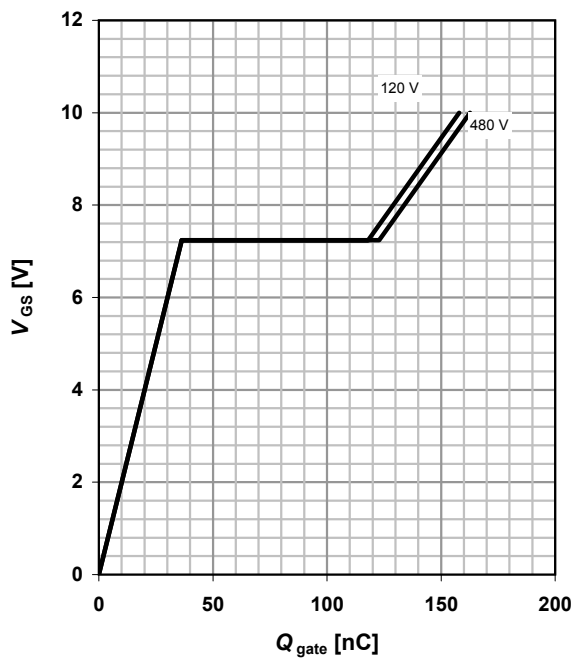
parameter: T_J 



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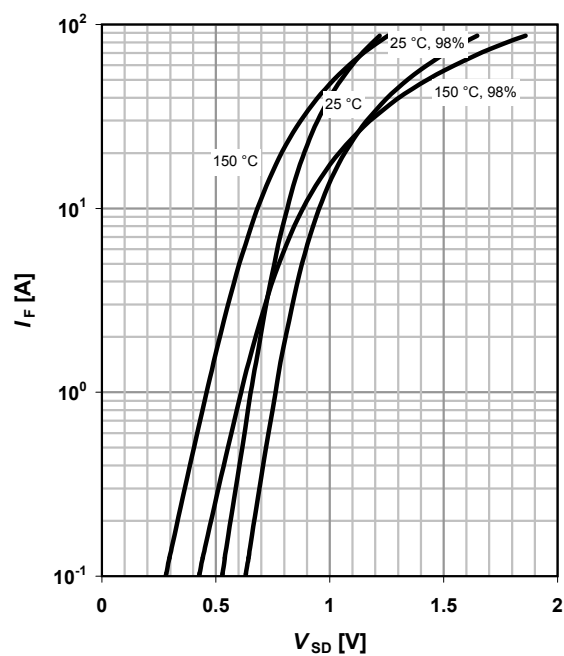
9 Typ. gate charge

$$V_{GS}=f(Q_{gate}); I_D=34.1 \text{ A pulsed}$$

parameter: V_{DD} 

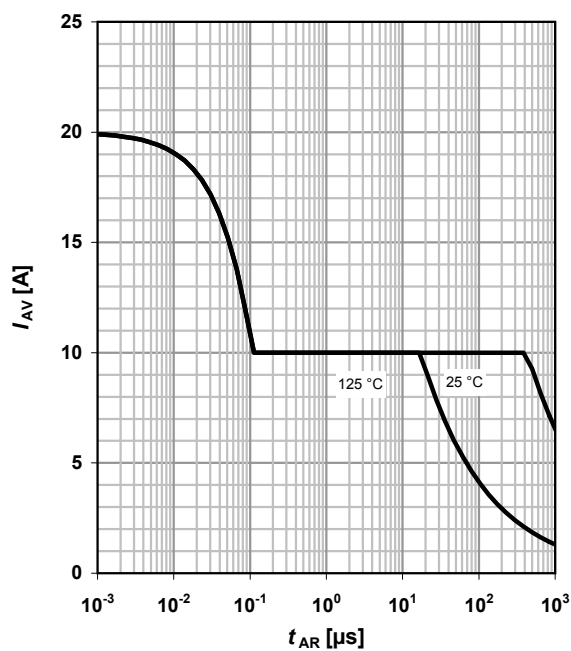
10 Forward characteristics of reverse diode

$$I_F=f(V_{SD})$$

parameter: T_j 

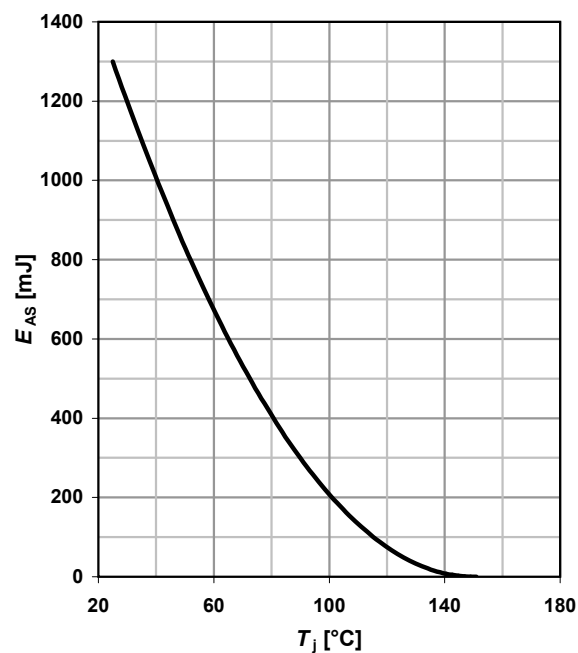
11 Avalanche SOA

$$I_{AR}=f(t_{AR})$$

parameter: $T_{j(start)}$ 

12 Avalanche energy

$$E_{AS}=f(T_j); I_D=10 \text{ A}; V_{DD}=50 \text{ V}$$

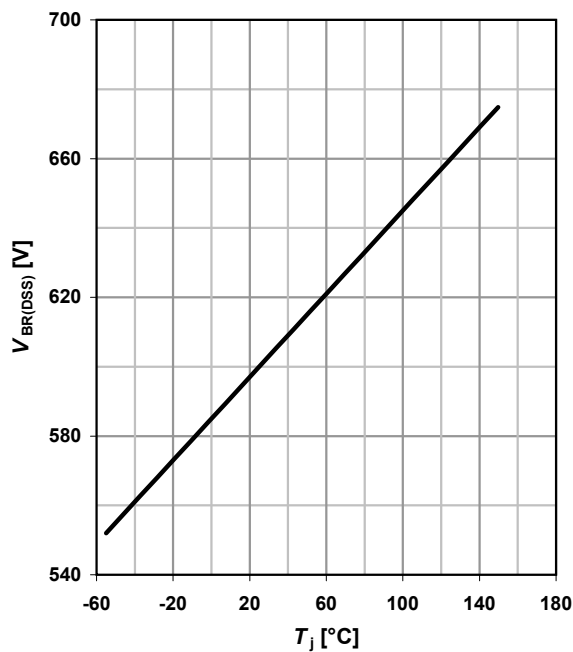




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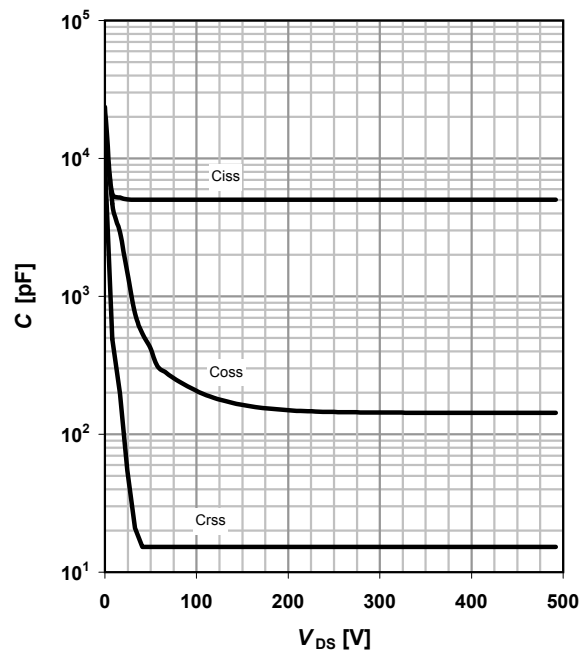
13 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = 10 \text{ mA}$$

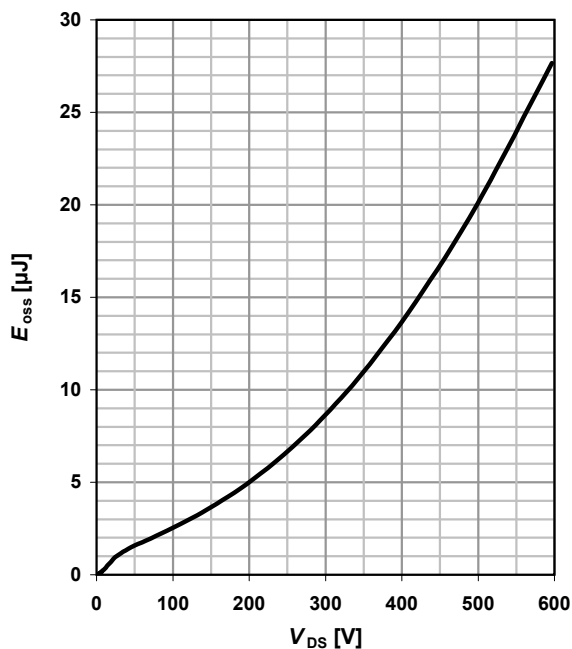


14 Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$

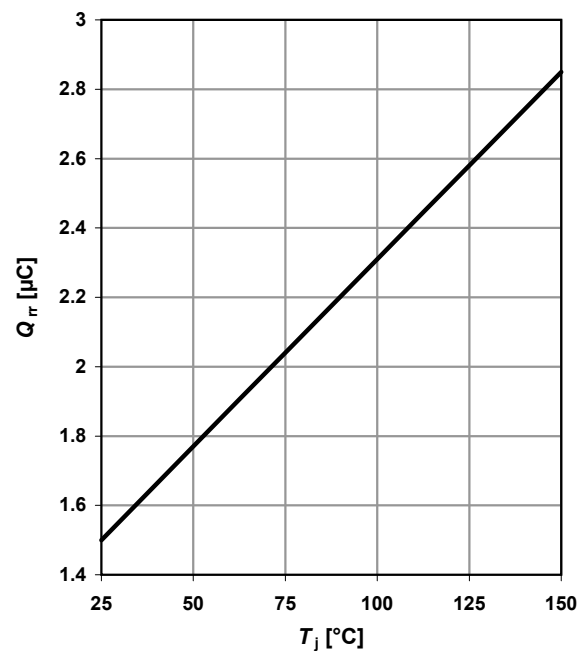
15 Typ. C_{oss} stored energy

$$E_{oss} = f(V_{DS})$$



16 Typ. reverse recovery charge

$$Q_{rr} = f(T_j); I_S = 34.1 \text{ A}; di/dt = 100 \text{ A/μs}$$

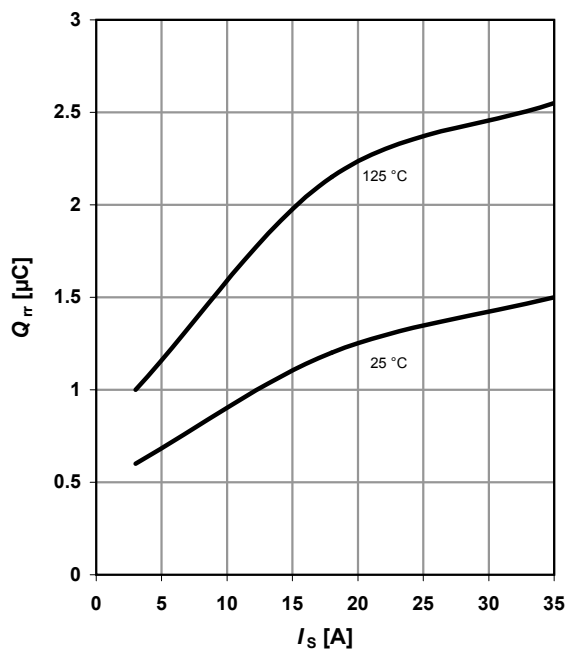




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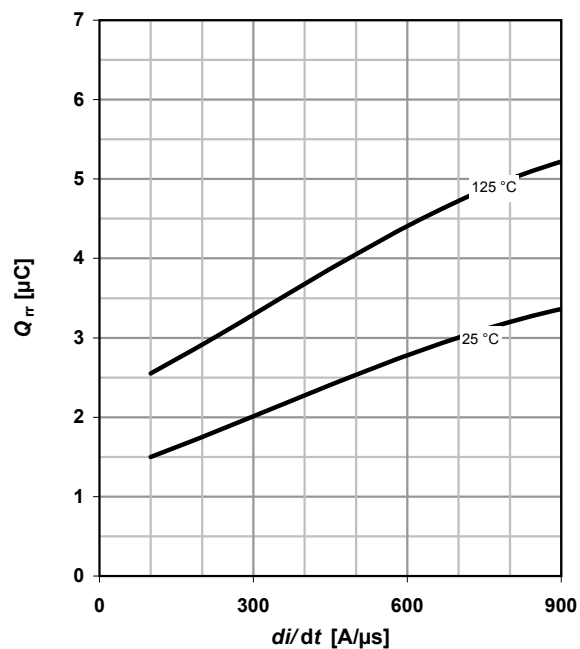
17 Typ. reverse recovery charge

$$Q_{rr}=f(I_S); di/dt=100 \text{ A}/\mu\text{s}$$

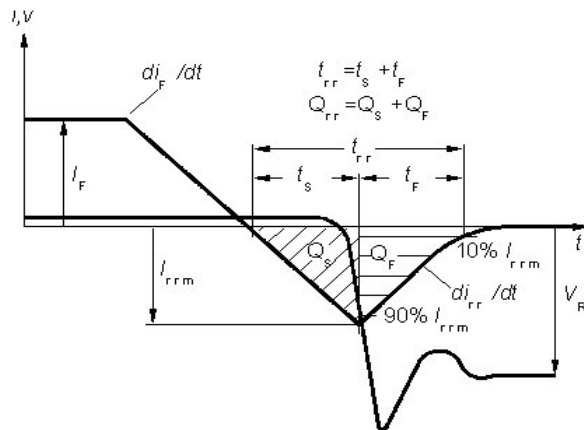
parameter: T_j 

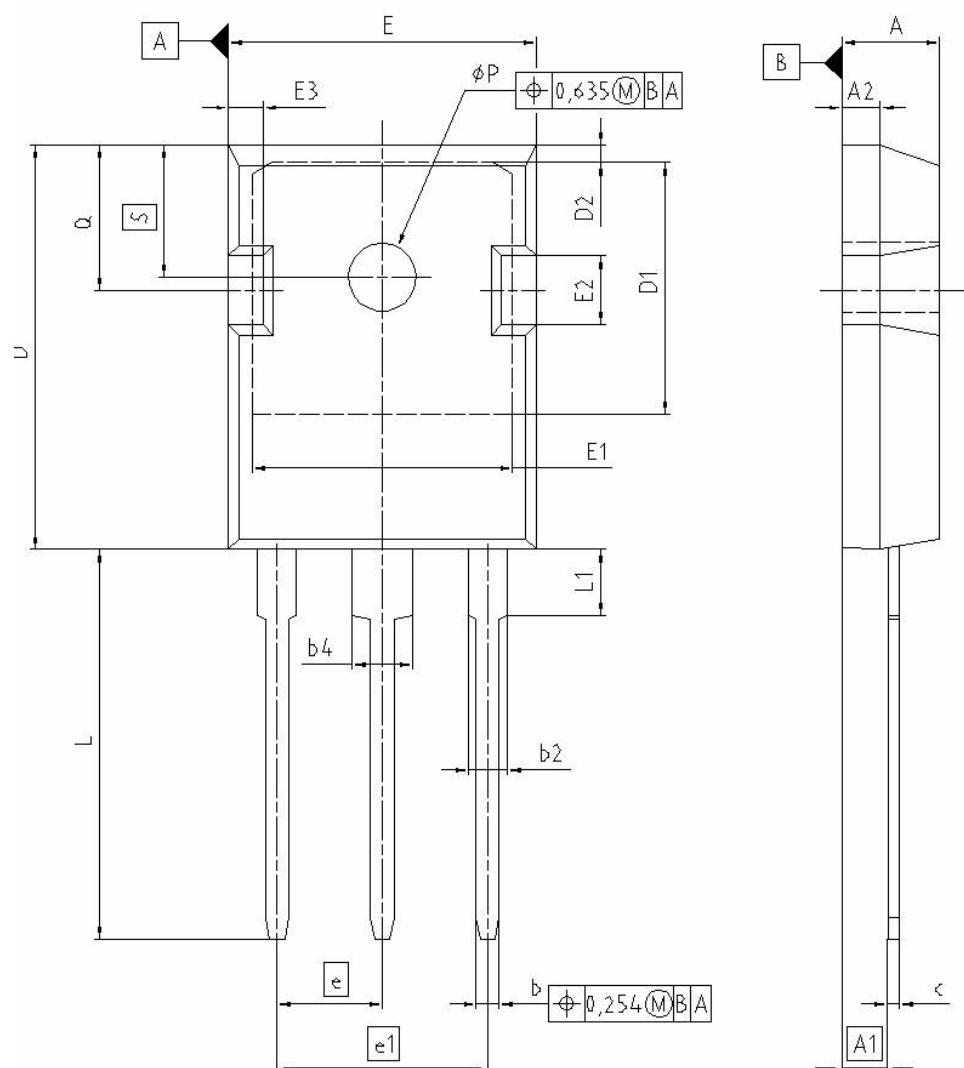
18 Typ. reverse recovery charge

$$Q_{rr}=f(di/dt); I_S=34.1 \text{ A}$$

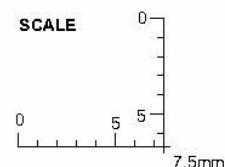
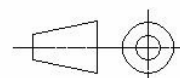
parameter: T_j 

Definition of diode switching characteristics





DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.903	5.157	0.193	0.203
A1	2.273	2.527	0.092	0.096
A2	1.853	2.107	0.075	0.081
b	1.073	1.327	0.047	0.052
b2	1.903	2.386	0.075	0.094
b4	2.870	3.454	0.113	0.136
c	0.549	0.752	0.024	0.030
D	20.823	21.077	0.820	0.830
D1	17.323	17.831	0.682	0.702
D2	1.063	1.317	0.042	0.052
E	15.773	16.027	0.621	0.631
E1	13.893	14.147	0.547	0.557
E2	3.683	3.937	0.145	0.155
E3	1.683	1.937	0.066	0.076
e	5.450		0.215	
e1	10.900		0.430	
N	3		3	
L	20.053	20.307	0.789	0.799
L1	4.168	4.472	0.164	0.176
øP	3.559	3.661	0.140	0.144
Q	5.493	5.747	0.216	0.226
S	6.043	6.297	0.238	0.248

REFERENCE
JEDEC TO247-AD
SCALE**EUROPEAN PROJECTION**
ISSUE DATE
28-06-2005

FILE
TO247_1



Published by
Infineon Technologies AG
Bereich Kommunikation
St.-Martin-Straße 53
D-81541 München
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